

## In-Amp Noise

Since in-amps are primarily used to amplify small precision signals, it is important to understand the effects of all the associated noise sources. The in-amp noise model is shown in Figure 1, below.



Figure 1: In-Amp Noise Model

There are two sources of input voltage noise. The first is represented as a noise source,  $V_{NI}$ , in series with the input, as in a conventional op amp circuit. This noise is reflected to the output by the in-amp gain, G. The second noise source is the output noise,  $V_{NO}$ , represented as a noise voltage in series with the in-amp output. The output noise, shown here referred to  $V_{OUT}$ , can be referred to the input by dividing by the gain, G.

There are also two noise sources associated with the input noise currents  $I_{N+}$  and  $I_{N-}$ . Even though  $I_{N+}$  and  $I_{N-}$  are usually equal ( $I_{N+} \approx I_{N-} = I_N$ ), they are *uncorrelated*, and therefore, the noise they each create must be summed in a root-sum-squares (rss) fashion.  $I_{N+}$  flows through one half of  $R_S$ , and  $I_{N-}$  the other half. This generates two noise voltages, each having an amplitude,  $I_N R_S/2$ . Each of these two noise sources is reflected to the output by the in-amp gain, G. The total output noise is calculated by combining all four noise sources in an rss manner:

NOISE(RTO) = 
$$\sqrt{BW} \sqrt{V_{NO}^2 + G^2 \left(V_{NI}^2 + \frac{I_{N+}^2 R_S^2}{4} + \frac{I_{N-}^2 R_S^2}{4}\right)}$$
. Eq. 1  
If  $I_{N+} = I_{N-} = I_N$ ,  
NOISE(RTO) =  $\sqrt{BW} \sqrt{V_{NO}^2 + G^2 \left(V_{NI}^2 + \frac{I_N^2 R_S^2}{2}\right)}$ . Eq. 2

The total noise, referred to the input (RTI) is simply the above expression divided by the in-amp gain, G:

NOISE(RTI) = 
$$\sqrt{BW} \sqrt{\frac{V_{NO}^2}{G^2} + \left(V_{NI}^2 + \frac{I_N^2 R_S^2}{2}\right)}$$
. Eq. 3

In-amp data sheets often present the total voltage noise RTI as a function of gain. This noise spectral density includes both the input  $(V_{NI})$  and output  $(V_{NO})$  noise contributions. The input current noise spectral density is specified separately.

As in the case of op amps, the total in-amp noise RTI must be integrated over the applicable inamp closed-loop bandwidth to compute an rms value. The bandwidth may be determined from data sheet curves that show frequency response as a function of gain.

Regarding this bandwidth, some care must be taken in computing it, as it is often *not* constant bandwidth product relationship, as is true with VFB op amps. In the case of the <u>AD620</u> in-amp family for example, the gain-bandwidth pattern is more like that of a CFB op amp. In such cases, the safest way to predict the bandwidth at a given gain is to use the curves supplied within the data sheet.

## REFERENCES

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